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#### What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

#### Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

#### Details

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Product Status	Obsolete
Core Processor	HCS12
Core Size	16-Bit
Speed	25MHz
Connectivity	CANbus, I <sup>2</sup> C, SCI, SPI
Peripherals	PWM, WDT
Number of I/O	91
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	2.35V ~ 5.25V
Data Converters	A/D 16x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	112-LQFP
Supplier Device Package	112-LQFP (20x20)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mc9s12dt128bcpv

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

#### Freescale Semiconductor, Inc. MC9S12D1128B Device User Guide — V01.09

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#### - Port M[7:6]

PM7:6 must be configured as outputs or their pull resistors must be enabled to avoid floating inputs.

– Port P6

PP6 must be configured as output or its pull resistor must be enabled to avoid a floating input.

- Port S[7:4]

PS7:4 must be configured as outputs or their pull resistors must be enabled to avoid floating inputs.

- PAD[15:8] (ATD1 channels)

Out of reset the ATD1 is disabled preventing current flows in the pins. Do not modify the ATD1 registers!

### **Document References**

The Device User Guide provides information about the MC9S12DT128B device made up of standard HCS12 blocks and the HCS12 processor core.

This document is part of the customer documentation. A complete set of device manuals also includes the HCS12 Core User Guide and all the individual Block User Guides of the implemented modules. In a effort to reduce redundancy all module specific information is located only in the respective Block User Guide. If applicable, special implementation details of the module are given in the block description sections of this document.

See **Table 0-2** for names and versions of the referenced documents throughout the Device User Guide.

User Guide	Version	Document Order Number
HCS12_V1.5 Core User Guide	1.2	HCS12COREUG
Clock and Reset Generator (CRG) Block User Guide	V03	S12CRGV3/D
Enhanced Capture Timer 16 Bit 8 Channel (ECT_16B8C) Block User Guide	V01	S12ECT16B8CV1/D
Analog to Digital Converter 10 Bit 8 Channel (ATD_10B8C) Block User Guide	V02	S12ATD10B8CV2/D
Inter IC Bus (IIC) Block User Guide	V02	S12IICV2/D
Asynchronous Serial Interface (SCI) Block User Guide	V02	S12SCIV2/D
Serial Peripheral Interface (SPI) Block User Guide	V02	S12SPIV2/D
Pulse Width Modulator 8 Bit 8 Channel (PWM_8B8C) Block User Guide	V01	S12PWM8B8CV1/D
128K Byte Flash (FTS128K) Block User Guide	V01	S12FTS128KV1/D
2K Byte EEPROM (EETS2K) Block User Guide	V01	S12EETS2KV1/D
Byte Level Data Link Controller -J1850 (BDLC) Block User Guide	V01	S12BDLCV1/D
Motorola Scalable CAN (MSCAN) Block User Guide	V02	S12MSCANV2/D
Voltage Regulator (VREG) Block User Guide	V01	S12VREGV1/D
Port Integration Module (PIM_9DT128) Block User Guide	V01	S12PIMDT128V1/D
Byteflight (BF) Block User Guide	V01	S12BFV1/D

**Table 0-2 Document References** 

\$00A0 - \$00C7

#### PWM (Pulse Width Modulator 8 Bit 8 Channel)

Address	Name	[	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$00A9	PWMSCLB	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00AA	PWMSCNTA	Read:	0	0	0	0	0	0	0	0
Φυυλά	Test Only	Write:								
\$00AB	PWMSCNTB	Read:	0	0	0	0	0	0	0	0
\$00/ L	Test Only	Write:	<b>D H H</b>							Dit o
\$00AC	PWMCNT0	Read:	Bit 7	6	5	4	3	2	1	Bit 0
		Write: Read:	0 Bit 7	0	0 5	0 4	0	0	0	0 Bit 0
\$00AD	PWMCNT1	Write:	<u>оп</u>	0	0	0	0	0	0	0
		Read:	Bit 7	6	5	4	3	2	1	Bit 0
\$00AE	PWMCNT2	Write:	0	0	0	0	0	0	0	0
<b>***</b>		Read:	Bit 7	6	5	4	3	2	1	Bit 0
\$00AF	PWMCNT3	Write:	0	0	0	0	0	0	0	0
¢ооро		Read:	Bit 7	6	5	4	3	2	1	Bit 0
\$00B0	PWMCNT4	Write:	0	0	0	0	0	0	0	0
\$00B1	PWMCNT5	Read:	Bit 7	6	5	4	3	2	1	Bit 0
ΨŪŪDI		Write:	0	0	0	0	0	0	0	0
\$00B2	PWMCNT6	Read:	Bit 7	6	5	4	3	2	1	Bit 0
<i><b></b></i>		Write:	0	0	0	0	0	0	0	0
\$00B3	PWMCNT7	Read:	Bit 7	6	5	4	3	2	1	Bit 0
		Write:	0	0	0	0	0	0	0	0
\$00B4	PWMPER0	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00B5	PWMPER1	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00B6	PWMPER2	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00B7	PWMPER3	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00B8	PWMPER4	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00B9	PWMPER5	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00BA	PWMPER6	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00BB	PWMPER7	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00BC	PWMDTY0	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00BD	PWMDTY1	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00BE	PWMDTY2	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00BF	PWMDTY3	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00C0	PWMDTY4	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0
\$00C1	PWMDTY5	Read: Write:	Bit 7	6	5	4	3	2	1	Bit 0

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#### \$00E8 - \$00EF

#### **BDLC (Byte Level Data Link Controller J1850)**

Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$00E8	DLCBCR1	Read:	IMSG	CLKS	0	0	0	0	IE	WCM
<b>WOOLO</b>	DEODOINI	Write:		OLINO						WOW
\$00E9	DLCBSVR	Read:	0	0	13	12	l1	10	0	0
\$00E9	DECROVIC	Write:								
\$00EA	DLCBCR2	Read:	SMRST	DLOOP	RX4XE	NBFS	TEOD	TSIFR	TMIFR1	TMIFR0
<b>WOLA</b>	DLCDCRZ	Write:		DLOOI	NA4AL	NDI 5	ILOD			
\$00EB	DLCBDR	Read:	D7	D6	D5	D4	D3	D2	D1	D0
<b>WOLD</b>	DLCDDK	Write:	וט	DO	5	D4	5	DZ		00
\$00EC	DLCBARD	Read:	0	RXPOL	0	0	BO3	BO2	BO1	BO0
<b>WOLC</b>	DECOARD	Write:		INAL OF			005	002	DOT	DOU
\$00ED	DLCBRSR	Read:	0	0	R5	R4	R3	R2	R1	R0
<b>JUDED</b>	DLCBRSR	Write:			КJ	Ν4	N3	NΖ		ΝU
¢00EE		Read:	0	0	0	BDLCE	0	0	0	0
\$00EE DLCSC	DLUGUK	Write:				BULCE				
\$00EF	DLCBSTAT	Read:	0	0	0	0	0	0	0	IDLE
φυυεγ	DLCBSTAT	Write:								

\$00F0 - \$00F7

#### **SPI1 (Serial Peripheral Interface)**

Address	Name	[	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$00F0	SPI1CR1	Read: Write:	SPIE	SPE	SPTIE	MSTR	CPOL	CPHA	SSOE	LSBFE
\$00F1	SPI1CR2	Read: Write:	0	0	0	MODFEN	BIDIROE	0	SPISWAI	SPC0
\$00F2	SPI1BR	Read: Write:	0	SPPR2	SPPR1	SPPR0	0	SPR2	SPR1	SPR0
\$00F3	SPI1SR	Read: Write:	SPIF	0	SPTEF	MODF	0	0	0	0
\$00F4	Reserved	Read: Write:	0	0	0	0	0	0	0	0
\$00F5	SPI1DR	Read: Write:	Bit7	6	5	4	3	2	1	Bit0
\$00F6	Reserved	Read: Write:	0	0	0	0	0	0	0	0
\$00F7	Reserved	Read: Write:	0	0	0	0	0	0	0	0

#### \$00F8 - \$00FF

#### Reserved

Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$00F8 - Reserved	Read:	0	0	0	0	0	0	0	0	
\$00FF	Reserved	Write:								

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\$0140 - \$017F

### CAN0 (Motorola Scalable CAN - MSCAN)

Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$0146	CAN0TFLG	Read:	0	0	0	0	0	TXE2	TXE1	TXE0
		Write: Read:	0	0	0	0	0			
\$0147	CAN0TIER	Write:	0	0	0	0	0	TXEIE2	TXEIE1	TXEIE0
\$0148	<b>CAN0TARQ</b>	Read:	0	0	0	0	0	ABTRQ2	ABTRQ1	ABTRQ0
φ01 <del>4</del> 0	CANUTARQ	Write:								
\$0149	CAN0TAAK	Read: Write:	0	0	0	0	0	ABTAK2	ABTAK1	ABTAK0
		Read:	0	0	0	0	0			
\$014A	CAN0TBSEL	Write:	•				•	TX2	TX1	TX0
\$014B	CAN0IDAC	Read:	0	0	IDAM1	IDAM0	0	IDHIT2	IDHIT1	IDHIT0
ψοτιΒ		Write:								
\$014C	Reserved	Read: Write:	0	0	0	0	0	0	0	0
<b>A</b> A 4 <b>A</b>		Read:	0	0	0	0	0	0	0	0
\$014D	Reserved	Write:								
\$014E	<b>CAN0RXERR</b>	Read:	RXERR7	RXERR6	RXERR5	RXERR4	RXERR3	RXERR2	RXERR1	RXERR0
<b>,</b> -		Write: Read:	TXERR7	TXERR6	TXERR5	TXERR4	TXERR3	TXERR2	TXERR1	TXERR0
\$014F	CAN0TXERR	Write:		INERRO	IVERKO	IAERR4	IVERKS	INERRZ	IVERKI	IAERRU
\$0150 -	CAN0IDAR0 -	Read:	AC7	AC6	AC5	AC4	AC3	AC2	AC1	AC0
\$0153	CAN0IDAR3	Write:	AC7	ACO	ACS	AC4	AC3	ACZ	ACT	ACU
\$0154 - \$0157	CAN0IDMR0 - CAN0IDMR3	Read: Write:	AM7	AM6	AM5	AM4	AM3	AM2	AM1	AM0
\$0158 -	CAN0IDAR4 - CAN0IDAR7	Read:	AC7	AC6	AC5	AC4	AC3	AC2	AC1	AC0
\$015B \$015C -	CANOIDAR7 CANOIDMR4 -	Write: Read:								
\$015C -	CANOIDMR7	Write:	AM7	AM6	AM5	AM4	AM3	AM2	AM1	AM0
\$0160 -	CAN0RXFG	Read:		FOF	REGROUN	D RECEIV	E BUFFER	see Table	1-2	
\$016F		Write:								
\$0170 - \$017F	CAN0TXFG	Read: Write:	FOREGROUND TRANSMIT BUFFER see Table 1-2							

#### Table 1-2 Detailed MSCAN Foreground Receive and Transmit Buffer Layout

		,								
Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	Extended ID	Read:	ID28	ID27	ID26	ID25	ID24	ID23	ID22	ID21
\$xxx0	Standard ID	Read:	ID10	ID9	ID8	ID7	ID6	ID5	ID4	ID3
	CANxRIDR0	Write:								
	Extended ID	Read:	ID20	ID19	ID18	SRR=1	IDE=1	ID17	ID16	ID15
\$xxx1	Standard ID	Read:	ID2	ID1	ID0	RTR	IDE=0			
	CANxRIDR1	Write:								
	Extended ID	Read:	ID14	ID13	ID12	ID11	ID10	ID9	ID8	ID7
\$xxx2	Standard ID	Read:								
	CANxRIDR2	Write:								
	Extended ID	Read:	ID6	ID5	ID4	ID3	ID2	ID1	ID0	RTR
\$xxx3	Standard ID	Read:								
	CANxRIDR3	Write:								
\$xxx4-	CANxRDSR0 -	Read:	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
\$xxxB	CANxRDSR7	Write:								

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#### \$0180 - \$01BF

#### CAN1 (Motorola Scalable CAN - MSCAN)

Address	Name	[	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	
\$0185	CAN1RIER	Read: Write:	WUPIE	CSCIE	RSTATE1	RSTATE0	TSTATE1	TSTATE0	OVRIE	RXFIE	
\$0186	CAN1TFLG	Read: Write:	0	0	0	0	0	TXE2	TXE1	TXE0	
\$0187	CAN1TIER	Read: Write:	0	0	0	0	0	TXEIE2	TXEIE1	TXEIE0	
\$0188	CAN1TARQ	Read: Write:	0	0	0	0	0	ABTRQ2	ABTRQ1	ABTRQ0	
\$0189	CAN1TAAK	Read: Write:	0	0	0	0	0	ABTAK2	ABTAK1	ABTAK0	
\$018A	CAN1TBSEL	Read: Write:	0	0	0	0	0	TX2	TX1	TX0	
\$018B	CAN1IDAC	Read: Write:	0	0	IDAM1	IDAM0	0	IDHIT2	IDHIT1	IDHIT0	
\$018C	Reserved	Read: Write:	0	0	0	0	0	0	0	0	
\$018D	Reserved	Read: Write:	0	0	0	0	0	0	0	0	
\$018E	CAN1RXERR	Read: Write:	RXERR7	RXERR6	RXERR5	RXERR4	RXERR3	RXERR2	RXERR1	RXERR0	
\$018F	CAN1TXERR	Read: Write:	TXERR7	TXERR6	TXERR5	TXERR4	TXERR3	TXERR2	TXERR1	TXERR0	
\$0190 - \$0193	CAN1IDAR0 - CAN1IDAR3	Read: Write:	AC7	AC6	AC5	AC4	AC3	AC2	AC1	AC0	
\$0194 - \$0197	CAN1IDMR0 - CAN1IDMR3	Read: Write:	AM7	AM6	AM5	AM4	AM3	AM2	AM1	AM0	
\$0198 - \$019B	CAN1IDAR4 - CAN1IDAR7	Read: Write:	AC7	AC6	AC5	AC4	AC3	AC2	AC1	AC0	
\$019C - \$019F	CAN1IDMR4 - CAN1IDMR7	Read: Write:	AM7	AM6	AM5	AM4	AM3	AM2	AM1	AM0	
\$01A0 - \$01AF	CANORXFG	Read: Write:	FOREGROUND RECEIVE BUFFER see Table 1-2								
\$01B0 - \$01BF	CAN0TXFG	Read: Write:		FOR	EGROUNI	D TRANSM	IT BUFFEI	R see <b>Tabl</b> e	e 1-2		

#### \$01C0 - \$01FF

#### Reserved

Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$01C0 - Deserved	Read:	0	0	0	0	0	0	0	0	
\$01FF	Reserved	Write:								

#### \$0200 - \$023F

#### Reserved

Address	Name	[	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$020C -	Reserved	Read:	0	0	0	0	0	0	0	0
\$023F	Reserveu	Write:								

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#### \$0240 - \$027F

#### **PIM (Port Integration Module)**

Address	Name		Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
\$0259	PTIP	Read:	PTIP7	PTIP6	PTIP5	PTIP4	PTIP3	PTIP2	PTIP1	PTIP0
ψ0200	1 111	Write:								
\$025A	DDRP	Read: Write:	DDRP7	DDRP7	DDRP5	DDRP4	DDRP3	DDRP2	DDRP1	DDRP0
\$025B	RDRP	Read: Write:	RDRP7	RDRP6	RDRP5	RDRP4	RDRP3	RDRP2	RDRP1	RDRP0
\$025C	PERP	Read: Write:	PERP7	PERP6	PERP5	PERP4	PERP3	PERP2	PERP1	PERP0
\$025D	PPSP	Read: Write:	PPSP7	PPSP6	PPSP5	PPSP4	PPSP3	PPSP2	PPSP1	PPSS0
\$025E	PIEP	Read: Write:	PIEP7	PIEP6	PIEP5	PIEP4	PIEP3	PIEP2	PIEP1	PIEP0
\$025F	PIFP	Read: Write:	PIFP7	PIFP6	PIFP5	PIFP4	PIFP3	PIFP2	PIFP1	PIFP0
\$0260	PTH	Read: Write:	PTH7	PTH6	PTH5	PTH4	PTH3	PTH2	PTH1	PTH0
\$0261	PTIH	Read: Write:	PTIH7	PTIH6	PTIH5	PTIH4	PTIH3	PTIH2	PTIH1	PTIH0
\$0262	DDRH	Read: Write:	DDRH7	DDRH7	DDRH5	DDRH4	DDRH3	DDRH2	DDRH1	DDRH0
\$0263	RDRH	Read: Write:	RDRH7	RDRH6	RDRH5	RDRH4	RDRH3	RDRH2	RDRH1	RDRH0
\$0264	PERH	Read: Write:	PERH7	PERH6	PERH5	PERH4	PERH3	PERH2	PERH1	PERH0
\$0265	PPSH	Read: Write:	PPSH7	PPSH6	PPSH5	PPSH4	PPSH3	PPSH2	PPSH1	PPSH0
\$0266	PIEH	Read: Write:	PIEH7	PIEH6	PIEH5	PIEH4	PIEH3	PIEH2	PIEH1	PIEH0
\$0267	PIFH	Read: Write:	PIFH7	PIFH6	PIFH5	PIFH4	PIFH3	PIFH2	PIFH1	PIFH0
\$0268	PTJ	Read: Write:	PTJ7	PTJ6	0	0	0	0	PTJ1	PTJ0
\$0269	PTIJ	Read: Write:	PTIJ7	PTIJ6	0	0	0	0	PTIJ1	PTIJ0
\$026A	DDRJ	Read: Write:	DDRJ7	DDRJ7	0	0	0	0	DDRJ1	DDRJ0
\$026B	RDRJ	Read: Write:	RDRJ7	RDRJ6	0	0	0	0	RDRJ1	RDRJ0
\$026C	PERJ	Read: Write:	PERJ7	PERJ6	0	0	0	0	PERJ1	PERJ0
\$026D	PPSJ	Read: Write:	PPSJ7	PPSJ6	0	0	0	0	PPSJ1	PPSJ0
\$026E	PIEJ	Read: Write:	PIEJ7	PIEJ6	0	0	0	0	PIEJ1	PIEJ0
\$026F	PIFJ	Read: Write:	PIFJ7	PIFJ6	0	0	0	0	PIFJ1	PIFJ0
\$0270 -	Reserved	Read:	0	0	0	0	0	0	0	0
\$027F		Write:								

### 2.3.21 PH6 / KWH6 — Port H I/O Pin 6

PH6 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode.

### 2.3.22 PH5 / KWH5 — Port H I/O Pin 5

PH5 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode.

### 2.3.23 PH4 / KWH4 -- Port H I/O Pin 2

PH4 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode.

### 2.3.24 PH3 / KWH3 / SS1 — Port H I/O Pin 3

PH3 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as slave select pin  $\overline{SS}$  of the Serial Peripheral Interface 1 (SPI1).

### 2.3.25 PH2 / KWH2 / SCK1 — Port H I/O Pin 2

PH2 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as serial clock pin SCK of the Serial Peripheral Interface 1 (SPI1).

### 2.3.26 PH1 / KWH1 / MOSI1 - Port H I/O Pin 1

PH1 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as master output (during master mode) or slave input pin (during slave mode) MOSI of the Serial Peripheral Interface 1 (SPI1).

### 2.3.27 PH0 / KWH0 / MISO1 — Port H I/O Pin 0

PH0 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as master input (during master mode) or slave output (during slave mode) pin MISO of the Serial Peripheral Interface 1 (SPI1).

### 2.3.28 PJ7 / KWJ7 / TXCAN4 / SCL - PORT J I/O Pin 7

PJ7 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as the transmit pin TXCAN for the Motorola Scalable Controller Area Network controller 4 (CAN4) or the serial clock pin SCL of the IIC module.

### 2.3.29 PJ6 / KWJ6 / RXCAN4 / SDA — PORT J I/O Pin 6

PJ6 is a general purpose input or output pin. It can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode. It can be configured as the receive pin RXCAN for the Motorola Scalable Controller Area Network controller 4 (CAN4) or the serial data pin SDA of the IIC module.

### 2.3.30 PJ[1:0] / KWJ[1:0] — Port J I/O Pins [1:0]

PJ1 and PJ0 are general purpose input or output pins. They can be configured to generate an interrupt causing the MCU to exit STOP or WAIT mode.

### 2.3.31 PK7 / ECS / ROMCTL - Port K I/O Pin 7

PK7 is a general purpose input or output pin. During MCU expanded modes of operation, this pin is used as the emulation chip select output ( $\overline{\text{ECS}}$ ). During MCU expanded modes of operation, this pin is used to enable the Flash EEPROM memory in the memory map (ROMCTL). At the rising edge of  $\overline{\text{RESET}}$ , the state of this pin is latched to the ROMON bit. For a complete list of modes refer to **4.2 Chip Configuration Summary**.

### 2.3.32 PK[5:0] / XADDR[19:14] — Port K I/O Pins [5:0]

PK5-PK0 are general purpose input or output pins. In MCU expanded modes of operation, these pins provide the expanded address XADDR[19:14] for the external bus.

### 2.3.33 PM7 / BF\_PSLM / TXCAN4 — Port M I/O Pin 7

PM7 is a general purpose input or output pin. It can be configured as the slot mismatch output pulse pin of Byteflight. It can be configured as the transmit pin TXCAN of the Motorola Scalable Controller Area Network controllers 4 (CAN4).

### 2.3.34 PM6 / BF\_PERR / RXCAN4 — Port M I/O Pin 6

PM6 is a general purpose input or output pin. It can be configured as the illegal pulse or message format error output pulse pin of Byteflight. It can be configured as the receive pin RXCAN of the Motorola Scalable Controller Area Network controllers 4 (CAN4).

### 2.3.35 PM5 / BF\_PROK / TXCAN0 / TXCAN4 / SCK0 — Port M I/O Pin 5

PM5 is a general purpose input or output pin. It can be configured as the reception OK output pulse pin of Byteflight. It can be configured as the transmit pin TXCAN of the Motorola Scalable Controller Area Network controllers 0 or 4 (CAN0 or CAN4). It can be configured as the serial clock pin SCK of the Serial Peripheral Interface 0 (SPI0).

### 2.4.4 VDDA, VSSA — Power Supply Pins for ATD and VREG

VDDA, VSSA are the power supply and ground input pins for the voltage regulator and the analog to digital converter. It also provides the reference for the internal voltage regulator. This allows the supply voltage to the ATD and the reference voltage to be bypassed independently.

### 2.4.5 VRH, VRL — ATD Reference Voltage Input Pins

VRH and VRL are the reference voltage input pins for the analog to digital converter.

### 2.4.6 VDDPLL, VSSPLL — Power Supply Pins for PLL

Provides operating voltage and ground for the Oscillator and the Phased-Locked Loop. This allows the supply voltage to the Oscillator and PLL to be bypassed independently. This 2.5V voltage is generated by the internal voltage regulator.

**NOTE:** No load allowed except for bypass capacitors.

### 2.4.7 VREGEN — On Chip Voltage Regulator Enable

Enables the internal 5V to 2.5V voltage regulator. If this pin is tied low, VDD1,2 and VDDPLL must be supplied externally.

## **Section 4 Modes of Operation**

## 4.1 Overview

Eight possible modes determine the operating configuration of the MC9S12DT128B. Each mode has an associated default memory map and external bus configuration controlled by a further pin.

Three low power modes exist for the device.

## 4.2 Chip Configuration Summary

The operating mode out of reset is determined by the states of the MODC, MODB, and MODA pins during reset (**Table 4-1**). The MODC, MODB, and MODA bits in the MODE register show the current operating mode and provide limited mode switching during operation. The states of the MODC, MODB, and MODA pins are latched into these bits on the rising edge of the reset signal. The ROMCTL signal allows the setting of the ROMON bit in the MISC register thus controlling whether the internal Flash is visible in the memory map. ROMON = 1 mean the Flash is visible in the memory map. The state of the ROMCTL pin is latched into the ROMON bit in the MISC register on the rising edge of the reset signal.

BKGD = MODC	PE6 = MODB	PE5 = MODA	PK7 = ROMCTL	ROMON Bit	Mode Description
0	0	0	х	1	Special Single Chip, BDM allowed and ACTIVE. BDM is allowed in all other modes but a serial command is required to make BDM active.
0	0	1	Х	0	Emulation Expanded Narrow, BDM allowed
0	1	0	Х	0	Special Test (Expanded Wide), BDM allowed
0	1	1	Х	0	Emulation Expanded Wide, BDM allowed
1	0	0	Х	1	Normal Single Chip, BDM allowed
1	0	1	0	0	Normal Expanded Narrow, RDM allowed
1	0	1	1	1	Normal Expanded Narrow, BDM allowed
1	1	0	х	1	Special Peripheral; BDM allowed but bus operations would cause bus conflicts (must not be used)
1	1	1	0	0	Normal Expanded Wide. BDM allowed
	I		1	1	- Normal Expanded Wide, DDW allowed

For further explanation on the modes refer to the Core User Guide.

#### Table 4-2 Clock Selection Based on PE7

PE7 = XCLKS	Description
1	Colpitts Oscillator selected
0	Pierce Oscillator/external clock selected

## Section 6 HCS12 Core Block Description

Consult the HCS12 Core User Guide for information about the HCS12 core modules, i.e. central processing unit (CPU), interrupt module (INT), module mapping control module (MMC), multiplexed external bus interface (MEBI), breakpoint module (BKP) and background debug mode module (BDM).

## 6.1 Device-specific information

When the BDM section of S12 Core User Guide refers to *alternate clock* this is equivalent to *oscillator clock*.

## Section 7 Clock and Reset Generator (CRG) Block Description

Consult the CRG Block User Guide for information about the Clock and Reset Generator module.

### 7.1 Device-specific information

## 7.1.1 XCLKS

The XCLKS input signal is active low (see 2.3.12 PE7 / NOACC / XCLKS — Port E I/O Pin 7).

## Section 8 Enhanced Capture Timer (ECT) Block Description

Consult the ECT\_16B8C Block User Guide for information about the Enhanced Capture Timer module. When the ECT\_16B8C Block User Guide refers to *freeze mode* this is equivalent to *active BDM mode*.

## Section 9 Analog to Digital Converter (ATD) Block Description

There are two Analog to Digital Converters (ATD1 and ATD0) implemented on the MC9S12DT128B. Consult the ATD\_10B8C Block User Guide for information about each Analog to Digital Converter module. When the ATD\_10B8C Block User Guide refers to *freeze mode* this is equivalent to *active BDM mode*.

## Section 10 Inter-IC Bus (IIC) Block Description

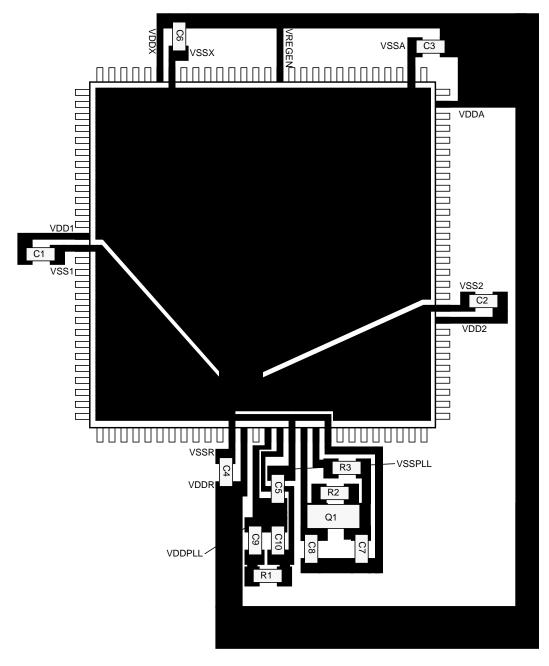


Figure 22-3 Recommended PCB Layout for 112LQFP Pierce Oscillator

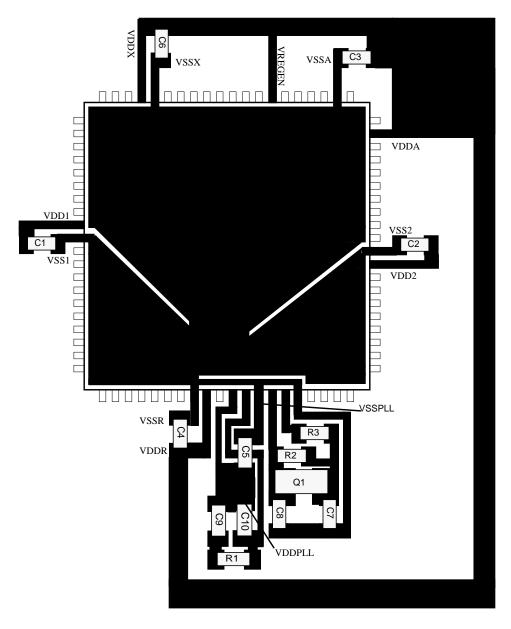


Figure 22-4 Recommended PCB Layout for 80QFP Pierce Oscillator

### A.1.5 Absolute Maximum Ratings

Absolute maximum ratings are stress ratings only. A functional operation under or outside those maxima is not guaranteed. Stress beyond those limits may affect the reliability or cause permanent damage of the device.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either V<sub>SS5</sub> or V<sub>DD5</sub>).

Num	Rating	Symbol	Min	Max	Unit
1	I/O, Regulator and Analog Supply Voltage	V <sub>DD5</sub>	-0.3	6.0	V
2	Digital Logic Supply Voltage <sup>2</sup>	V <sub>DD</sub>	-0.3	3.0	V
3	PLL Supply Voltage <sup>2</sup>	V <sub>DDPLL</sub>	-0.3	3.0	V
4	Voltage difference VDDX to VDDR and VDDA	$\Delta_{VDDX}$	-0.3	0.3	V
5	Voltage difference VSSX to VSSR and VSSA	Δ <sub>VSSX</sub>	-0.3	0.3	V
6	Digital I/O Input Voltage	V <sub>IN</sub>	-0.3	6.0	V
7	Analog Reference	V <sub>RH,</sub> V <sub>RL</sub>	-0.3	6.0	V
8	XFC, EXTAL, XTAL inputs	V <sub>ILV</sub>	-0.3	3.0	V
9	TEST input	V <sub>TEST</sub>	-0.3	10.0	V
10	Instantaneous Maximum Current Single pin limit for all digital I/O pins <sup>3</sup>	I <sub>D</sub>	-25	+25	mA
11	Instantaneous Maximum Current Single pin limit for XFC, EXTAL, XTAL <sup>4</sup>	I <sub>DL</sub>	-25	+25	mA
12	Instantaneous Maximum Current Single pin limit for TEST <sup>5</sup>	I <sub>DT</sub>	-0.25	0	mA
13	Storage Temperature Range	T <sub>stg</sub>	- 65	155	°C

Table A-1	Absolute	Maximum	Ratings <sup>1</sup>
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NOTES:

1. Beyond absolute maximum ratings device might be damaged.

2. The device contains an internal voltage regulator to generate the logic and PLL supply out of the I/O supply. The absolute maximum ratings apply when the device is powered from an external source.

3. All digital I/O pins are internally clamped to  $V_{SSX}$  and  $V_{DDX}$ ,  $V_{SSR}$  and  $V_{DDR}$  or  $V_{SSA}$  and  $V_{DDA}$ . 4. Those pins are internally clamped to  $V_{SSPLL}$  and  $V_{DDPLL}$ . 5. This pin is clamped low to  $V_{SSPLL}$ , but not clamped high. This pin must be tied low in applications.

### A.1.6 ESD Protection and Latch-up Immunity

All ESD testing is in conformity with CDF-AEC-Q100 Stress test qualification for Automotive Grade Integrated Circuits. During the device qualification ESD stresses were performed for the Human Body Model (HBM), the Machine Model (MM) and the Charge Device Model.

### A.2 ATD Characteristics

This section describes the characteristics of the analog to digital converter.

### A.2.1 ATD Operating Characteristics

The Table A-8 shows conditions under which the ATD operates.

The following constraints exist to obtain full-scale, full range results:

 $V_{SSA} \le V_{RL} \le V_{IN} \le V_{RH} \le V_{DDA}$ . This constraint exists since the sample buffer amplifier can not drive beyond the power supply levels that it ties to. If the input level goes outside of this range it will effectively be clipped.

Condit	tions	s are shown in Table A-4 unless otherwise noted					
Num	С	Rating	Symbol	Min	Тур	Max	Unit
1	D	Reference Potential Low High	V <sub>RL</sub> V <sub>RH</sub>	V <sub>SSA</sub> V <sub>DDA</sub> /2		V <sub>DDA</sub> /2 V <sub>DDA</sub>	V V
2	С	Differential Reference Voltage <sup>1</sup>	$V_{RH}-V_{RL}$	4.50	5.00	5.25	V
3	D	ATD Clock Frequency	f <sub>ATDCLK</sub>	0.5		2.0	MHz
4	D	ATD 10-Bit Conversion Period Clock Cycles <sup>2</sup> Conv, Time at 2.0MHz ATD Clock f <sub>ATDCLK</sub>		14 7		28 14	Cycles μs
5	D	ATD 8-Bit Conversion Period Clock Cycles <sup>(2)</sup> Conv, Time at 2.0MHz ATD Clock f <sub>ATDCLK</sub>	N <sub>CONV8</sub> T <sub>CONV8</sub>	12 6		26 13	Cycles μs
6	D	Stop Recovery Time (V <sub>DDA</sub> =5.0 Volts)	t <sub>SR</sub>			20	μs
7	Р	Reference Supply current (Both ATD modules on)	I <sub>REF</sub>			0.75	mA
8	Р	Reference Supply current (Only one ATD module on)	I <sub>REF</sub>			0.375	mA

#### Table A-8 ATD Operating Characteristics

NOTES:

1. Full accuracy is not guaranteed when differential voltage is less than 4.50V

2. The minimum time assumes a final sample period of 2 ATD clocks cycles while the maximum time assumes a final sample period of 16 ATD clocks.

### A.2.2 Factors influencing accuracy

Three factors – source resistance, source capacitance and current injection – have an influence on the accuracy of the ATD.

### A.2.2.1 Source Resistance:

Due to the input pin leakage current as specified in **Table A-6** in conjunction with the source resistance there will be a voltage drop from the signal source to the ATD input. The maximum source resistance  $R_S$ 

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specifies results in an error of less than 1/2 LSB (2.5mV) at the maximum leakage current. If device or operating conditions are less than worst case or leakage-induced error is acceptable, larger values of source resistance is allowed.

#### A.2.2.2 Source capacitance

When sampling an additional internal capacitor is switched to the input. This can cause a voltage drop due to charge sharing with the external and the pin capacitance. For a maximum sampling error of the input voltage  $\leq 1LSB$ , then the external filter capacitor,  $C_f \geq 1024 * (C_{INS} - C_{INN})$ .

#### A.2.2.3 Current injection

There are two cases to consider.

- 1. A current is injected into the channel being converted. The channel being stressed has conversion values of 3FF (FF in 8-bit mode) for analog inputs greater than  $V_{RH}$  and 000 for values less than  $V_{RL}$  unless the current is higher than specified as disruptive conditions.
- 2. Current is injected into pins in the neighborhood of the channel being converted. A portion of this current is picked up by the channel (coupling ratio K), This additional current impacts the accuracy of the conversion depending on the source resistance.

The additional input voltage error on the converted channel can be calculated as  $V_{ERR} = K * R_S * I_{INJ}$ , with  $I_{INJ}$  being the sum of the currents injected into the two pins adjacent to the converted channe

Condit	tion	s are shown in Table A-4 unless otherwise noted					
Num	С	Rating	Symbol	Min	Тур	Max	Unit
1	С	Max input Source Resistance	R <sub>S</sub>	-	-	1	KΩ
2	т	Total Input Capacitance Non Sampling Sampling	C <sub>INN</sub> C <sub>INS</sub>			10 22	pF
3	С	Disruptive Analog Input Current	I <sub>NA</sub>	-2.5		2.5	mA
4	С	Coupling Ratio positive current injection	K <sub>p</sub>			10 <sup>-4</sup>	A/A
5	С	Coupling Ratio negative current injection	K <sub>n</sub>			10 <sup>-2</sup>	A/A

#### Table A-9 ATD Electrical Characteristics

This is very important to notice with respect to timers, serial modules where a pre-scaler will eliminate the effect of the jitter to a large extent.

Condit	ions	s are shown in Table A-4 unless otherwise noted					
Num	С	Rating	Symbol	Min	Тур	Max	Unit
1	Р	Self Clock Mode frequency	f <sub>SCM</sub>	1		5.5	MHz
2	D	VCO locking range	f <sub>VCO</sub>	8		50	MHz
3	D	Lock Detector transition from Acquisition to Tracking mode	$ \Delta_{trk} $	3		4	% <sup>1</sup>
4	D	Lock Detection	$ \Delta_{Lock} $	0		1.5	%(1)
5	D	Un-Lock Detection	$ \Delta_{unl} $	0.5		2.5	%(1)
6	D	Lock Detector transition from Tracking to Acquisition mode	Δ <sub>unt</sub>	6		8	%(1)
7	С	PLLON Total Stabilization delay (Auto Mode) <sup>2</sup>	t <sub>stab</sub>		0.5		ms
8	D	PLLON Acquisition mode stabilization delay <sup>(2)</sup>	t <sub>acq</sub>		0.3		ms
9	D	PLLON Tracking mode stabilization delay <sup>(2)</sup>	t <sub>al</sub>		0.2		ms
10	D	Fitting parameter VCO loop gain	K <sub>1</sub>		-120		MHz/V
11	D	Fitting parameter VCO loop frequency	f <sub>1</sub>		75		MHz
12	D	Charge pump current acquisition mode	∣i <sub>ch</sub> ∣		38.5		μA
13	D	Charge pump current tracking mode	∣i <sub>ch</sub> ∣		3.5		μA
14	С	Jitter fit parameter 1 <sup>(2)</sup>	j <sub>1</sub>			1.1	%
15	С	Jitter fit parameter 2 <sup>(2)</sup>	j <sub>2</sub>			0.13	%

NOTES:

1. % deviation from target frequency

2. f<sub>OSC</sub> = 4MHz, f<sub>BUS</sub> = 25MHz equivalent f<sub>VCO</sub> = 50MHz: REFDV = #\$03, SYNR = #\$018, Cs = 4.7nF, Cp = 470pF, Rs = 10KΩ.